Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/578,309	BLANC ET AL.
Examiner	Art Unit
Y. J. Han	2838

SEARCHED				
Class	Subclass	Date	Examiner	
363	40			
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307	82			
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INTERFERENCE SEARCHED			
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See search report		3/5/2007	JH

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